

L Number	Hits	Search Text	DB	Time stamp
-	92	@ad<=19980907 and 'ferroelectric transistor'	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/02/14 13:35
-	1	"4047214".PN.	USPAT	2002/09/09 09:51
-	1	"4161038".PN.	USPAT	2002/09/09 09:51
-	1	"5424238".PN.	USPAT	2002/09/09 09:51
-	1	"5654568".PN.	USPAT	2002/09/09 09:52
-	1	"3808674".PN.	USPAT	2002/09/09 10:02
-	1	"5146299".PN.	USPAT	2002/09/09 10:02
-	1	"5361225".PN.	USPAT	2002/09/09 10:02
-	1	"5424238".PN.	USPAT	2002/09/09 10:02
-	3397	((438/3) or (257/295-296)).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/09/09 10:22
-	2344	((438/3) or (257/295-296)).CCLS.) and @ad<=19980907	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/02/13 14:48
-	1	"4460670".PN.	USPAT	2002/09/09 10:36
-	658	((438/3) or (257/295-296)).CCLS.) and @ad<=19980907) and 'ferroelectric'	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/09/09 10:46
-	1	"5530668".PN.	USPAT	2002/09/09 11:09
-	1	"5530667".PN.	USPAT	2002/09/09 11:09
-	1	"5317533".PN.	USPAT	2002/09/09 11:10
-	1	"5289408".PN.	USPAT	2002/09/09 11:10
-	0	@ad<=19980907 and 'ferroelectric transistor' with surrounding adj gate	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/02/13 15:42
-	0	@ad<=19980907 and 'ferroelectric' with surrounding adj gate	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/09/09 11:58
-	31	@ad<=19980907 and 'ferroelectric' and 'surrounding gate transistor'	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/02/14 11:08
-	1191	((257/324) or (257/410-411)).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/02/13 14:48
-	954	((257/324) or (257/410-411)).CCLS.) and @ad<=19980907	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/09/09 14:58
-	46	((257/324) or (257/410-411)).CCLS.) and @ad<=19980907) and ferroelectric	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/09/09 14:58
-	45	@ad<=19980907 and 'gate dielectric' with 'ferroelectric'	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2002/09/09 15:47

	311	@ad<=19980907 and ferroelectric near transistor	USPAT; US_PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/09/10 08:52
	2	@ad<=19980907 and 'gate insulator' with 'ferroelectric' and 'polysilicon gate'	USPAT; US_PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/09/10 08:57
	7813	@ad<=19980907 and 'polysilicon gate'	USPAT; US_PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/09/10 11:56
	79	(@ad<=19980907 and 'polysilicon gate') and ferroelectric	USPAT; US_PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/09/10 12:04
	13	@ad<=19980907 and 'ferroelectric transistor' and 'diode'	USPAT; US_PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/09/10 11:46
	1149	@ad<=19980907 and 'stacked gate'	USPAT; US_PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/09/10 11:02
	14	(@ad<=19980907 and 'stacked gate') and ferroelectric	USPAT; US_PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/09/10 11:02
	477	@ad<=19980907 and 'doped polysilicon gates'	USPAT; US_PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/09/10 11:58
	6	@ad<=19980907 and 'polysilicon gates' with 'high dielectric'	USPAT; US_PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/09/10 12:05
	6	@ad<=19980907 and 'polysilicon gates' with 'ferroelectric'	USPAT; US_PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/09/10 12:06
	3	@ad<=19980907 and 'polysilicon gates' with ferroelectric with dielectric	USPAT; US_PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/09/10 12:11
	1041	@ad<=19980907 and ferroelectric with gate	USPAT; US_PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/09/10 12:12
	6	@ad<=19980907 and ferroelectric with 'polysilicon gate'	USPAT; US_PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/09/10 12:12
	1264	((257/324) or (257/410-411)).CCLS.	USPAT; US_PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/02/13 14:49

	162	(438/239).CCLS. and @ad<=19980907	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/02/13 15:08
	4	(("5731608") or ("5932904")).PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/02/13 15:09
	331	(438/3).CCLS. and @ad<=19980907	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/02/13 15:33
	512	(257/295).CCLS. and @ad<=19980907	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/02/14 11:12
	1614	(257/296).CCLS. and @ad<=19980907	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/02/13 15:35
	269	(257/300).CCLS. and @ad<=19980907	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/02/13 15:40
	220	(257/756).CCLS. and @ad<=19980907	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/02/13 15:40
	92	@ad<=19980907 and 'ferroelectric transistor'	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/02/14 11:25
	485	@ad<=19980907 and 'gate' same 'N' adj1 'doped' same 'P' adj1 'doped'	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/02/13 16:11
	5	@ad<=19980907 and 'gate' same 'N' adj1 'doped' same 'P' adj1 'doped' and 'ferroelectric'	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/02/13 16:11
	18	@ad<=19980907 and 'polysilicon gate' same 'ferroelectric'	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/02/13 16:12
	31	@ad<=19980907 and 'ferroelectric' and 'surrounding gate transistor'	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/02/14 11:08
	385	(257/310).CCLS. and @ad<=19980907	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/02/14 11:13
	596	(257/288).CCLS. and @ad<=19980907	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/02/14 11:14

-	2	("5266829").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/02/14 13:41
-	2	("4943538").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB	2003/02/14 13:41